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## First-principles equation-of-state (FPEOS) table of silicon and its effects on highenergy-density plasma simulations

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Using density-functional theory-based molecular-dynamics simulations, we have investigated the equation of state for silicon in a wide range of plasma density/temperature conditions of  $\rho = 0.001$  to 500 g/cm<sup>3</sup> and T = 2000 to 10<sup>8</sup> K. With these calculations, we have established a first-principles equation-of-state (FPEOS) table of silicon for high-energy-density (HED) plasma simulations. When compared with the widely used *SESAME*-EOS model (Table 3810), we find that the FPEOS-predicted Hugoniot is ~20% softer; for off-Hugoniot plasma conditions, the pressure and internal energy in FPEOS are lower than those of *SESAME* EOS for temperatures above  $T \approx 1$  to 10 eV (depending on density), while the former becomes higher in the low-*T* regime. The pressure difference between FPEOS and *SESAME* 3810 can reach to ~50%, especially in the warm-dense-matter regime. Implementing the FPEOS table of silicon into our hydrocodes, we have studied its effects on Si-target implosions. When compared with the one-dimensional radiation-hydrodynamics simulation using the *SESAME* 3810 EOS model, the FPEOS simulation showed that (1) the shock speed in silicon is ~10% slower; (2) the peak density of an in-flight Si shell during implosion is ~20% higher than the *SESAME* 3810 simulation; (3) the maximum density reached in the FPEOS simulation is ~40% higher at the peak compression; and (4) the final areal density and neutron yield are, respectively, ~30% and ~70% higher predicted by FPEOS versus the traditional simulation using *SESAME* 3810. All of these features can be attributed to the larger compressibility of silicon predicted by FPEOS. These results indicate that an accurate EOS table, like the FPEOS presented here, could be essential for the precise design of targets for HED experiments.

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### I. INTRODUCTION

As one of the most-abundant elements on Earth, silicon is important to many different fields ranging from the semiconductor industry,<sup>1</sup> geophysics,<sup>2</sup> photovoltaics,<sup>3</sup> planetary and astrophysics,<sup>4–6</sup> to inertial confinement fusion (ICF) physics studies.<sup>7–9</sup> For ICF applications, silicon has been used as dopants to ablators in indirect-drive ICF target designs.<sup>10</sup> It has also been applied to mitigate laser-imprint effects<sup>11,12</sup> and the two-plasmon–decay instability<sup>13,14</sup> for multilayer target designs in direct-drive ICF implosions.<sup>15</sup> For these high-energy-density (HED) applications, it is essential to know

the properties of silicon under extreme conditions. The equation of state (EOS) of silicon is one of such intrinsic properties that are crucial to both ICF and geophysics applications since it is needed for hydrodynamic simulations of ICF implosions and for understanding the geophysics of the earth's outer core.<sup>2</sup>

The EOS studies of silicon under megabar (Mbar) pressures began in the 1960s (Ref. 16) using explosive drive. The principal Hugoniot measurements of silicon were continued in the 1970s and 1980s by different groups.<sup>17,18</sup> Many surprises were found in our understanding the behavior of shocks in silicon. For instance, the elastic behavior of shocks was observed in silicon even at Mbar pressures.<sup>19</sup> Namely, the lattice reduction related to shock compression may occur only along the shock-propagation direction, instead of hydrostatical lattice-shrinking in all three dimensions. Furthermore, the measured optical emission from shocked silicon was found to be much lower than expected, which has been hypothesized to be caused by the unusually long electron–ion equilibration time in silicon shock.<sup>20–22</sup> These abnormal phenomena have been observed in shock experiments up to ~6-Mbar pressures. What might occur for silicon under extreme pressures (>10 Mbar) remains to be seen. To the best of our knowledge, these anomalies observed in shocked silicon are not fully understood. To this end, a thorough understanding of silicon properties under HED conditions is necessary.

Theoretical investigations on shock compressions of silicon have been performed by classical molecular-dynamics methods,  $2^{3-25}$  quantum molecular-dynamics simulations based on density functional theory (DFT),  $2^{6-29}$  and path-integral Monte Carlo (PIMC) modeling.  $2^{7,29}$  Most of these studies have been devoted to the moderatepressure regime of P < 2 Mbar, while the two most-recent first-principles calculations<sup>27,29</sup> extended the Hugoniot pressures from ~1 Mbar to over ~10 Gbar for the first time. These calculations combined the orbital-based–DFT Kohn–Sham molecular-dynamics (KSMD) method, the orbital-free–DFT molecular-dynamics (OFMD) method, and the PIMC simulation. All three first-principles calculations are in good agreement in predicting the principal Hugoniot of silicon, which was found to be ~20% softer than both the extensively used *SESAME*-EOS model<sup>30</sup> (Table 3810) and the quotidian equation-of-state (QEOS) model.<sup>31</sup> The predicted softening of silicon should have important implications for HED simulations of silicon plasmas. However, the calculations presented in Ref. [29] are only concerned the plasma conditions along the principal Hugoniot. To assess how such a softening behavior of silicon affects HED plasma simulations, we must expand our first-principles calculations to cover a wide range of off-Hugoniot plasma conditions, which is essential to our mounting of 1D radiation-hydrodynamics simulations for NIF-type direct-drive capsule implosions.

For this paper, we calculated EOS for a wide range of silicon plasma conditions by using DFT-based molecular-dynamics simulations. To be specific, we have sampled silicon densities from  $\rho = 0.001$  g/cm<sup>3</sup> to  $\rho = 500$  g/cm<sup>3</sup> and temperatures from T =2000 K to  $T = 10^8$  K. Based on these *ab-initio* calculations, we have built a firstprinciples equation-of-state (FPEOS) table of silicon for ICF and HED applications. For off-Hugoniot conditions, we have investigated the difference in pressure and internal energy between FPEOS and *SESAME* EOS. Implementing the FPEOS table of silicon into the one-dimensional (1-D) hydrocode *LILAC*<sup>32</sup>, we have tested its effects on HED plasma simulations of ICF implosions using a Si ablator. Comparisons with traditional *SESAME*-EOS simulations illustrated the need for more-accurate EOS tables to precisely design ICF and HED experiments.

This paper is organized as follows: First, the details of our first-principles calculations are described in Sec. II. For completeness, the principal Hugoniot comparison is included in Sec. III, even though it has been reported elsewhere.<sup>29</sup> The FPEOS and *SESAME* EOS are also compared in Sec. III for different isochoric plasma conditions. In Sec. IV, the effects of the FPEOS table on HED plasmas through *LILAC* simulations of ICF implosions using a silicon layer as the ablator are presented. Finally, our conclusions are presented in Sec. V.

## II. MOLECULAR-DYNAMICS SIMULATIONS BASED ON THE DENSITY FUNCTIONAL THEORY

First-principles methods, such as DFT-based quantum molecular-dynamics (QMD),<sup>33–36</sup> path-integral Monte Carlo (PIMC),<sup>37</sup> and quantum Monte Carlo (QMC),<sup>38,39</sup> have been developed over the past decades to understand the properties of materials under extreme conditions. Two different flavors of QMD have been implemented by the condensed-matter and HED physics communities. One uses the orbital-based Kohn–Sham formalism<sup>40</sup> with the finite-temperature density-functional theory, in conjunction with the molecular-dynamics method for ion motion (denoted here as "KSMD"). The other is the orbital-free molecular-dynamics (OFMD) method,<sup>41</sup> which is based on the original DFT idea that the free energy of a many-electron system can be written as a function solely depending on the electron density. For most cases, the KSMD method has been proven to be an accurate and efficient method for calculating

material properties under high compression at temperatures generally below the electron Fermi temperature  $T_{\rm F}$ . It becomes impractical for high-temperature ( $T > T_{\rm F}$ ) simulations because thermal excitation of electrons requires a large number of orbitals for convergence. The OFMD method is a natural extension of the KSMD method for high-Tmaterial simulations, even though it is not as accurate as KSMD. Nevertheless, the pressure difference between KSMD and OFMD calculations is still within ~1% in the overlapping regime of  $T \sim T_{\rm F}$  (valid for both methods), which is acceptable for general ICF/HED applications.

We have used the Vienna *ab initio* Simulation Package (VASP)<sup>42–44</sup> for KSMD simulations, in which electrons are treated quantum-mechanically with a plane-wave finite-temperature DFT description. The electrons and ions of the material are in thermodynamic equilibrium with equal temperature ( $T_e = T_i$ ). The electron–ion Coulomb interaction is represented by a projector augumented-wave (PAW) pseudopotential with "frozen" 1*s*-core electrons. The electron exchange-correlation potential is described by the generalized-gradient approximation (GGA) with the Perdew–Burke–Ernzerhof (PBE) functional,<sup>45</sup> Under the Born–Oppenheimer approximation, the self-consistent electron density is first determined for an ion configuration. Then, the classical ions are moved by the combined electronic and ionic forces, using Newton's equation. This molecular-dynamics procedure is repeated for thousands of time steps from which the thermodynamic EOS quantities such as pressure and internal energy can be directly calculated.

In our KSMD simulations, we have employed the  $\Gamma$  point (**k** = 0) sampling of the Brillouin zone. We used either 32 or 64 Si atoms (depending on density) in a cubic cell

with a periodic boundary condition. The cubic cell size is determined from the mass density. The PAW potential of Si included 12 active electrons; the plane-wave cutoff energy was set to 2000 eV. In all KSMD simulations, a sufficient number of bands (varying from 500 to 4100) were included such that the occupation of the highest band was less than 10<sup>-5</sup>. The time step varied from  $\delta t = 1.5$  fs to  $\delta t = 0.085$  fs, respectively, for the lowest and highest densities ( $\rho_{min} = 0.1$  g/cm<sup>3</sup> and  $\rho_{max} = 50$  g/cm<sup>3</sup>). Good convergence was obtained for these parameter sets. The sampled temperature points varied from T = 2000 K to a maximum temperature of T = 500,000 K. Outside these density and temperature ranges, we switched to the OFMD calculations since the 1*s*-core electrons must be included in the EOS calculations.

The OFMD method<sup>41</sup> originated from the true spirit of the Hohenberg–Kohn theorem,<sup>46</sup> i.e., the free energy of an electron–ion system at any ion configuration can be written as a function of the electron density. The kinetic energy of the electrons is currently represented by the Thomas–Fermi functional (with the possibility of adding the von Weizsäcker correction that takes into account the gradient of electron density.) These terms were obtained from the semiclassical expansion of the partition function up to the first order. In OFMD simulations, all electrons, both bound and free, are treated on equal footing. The divergence of the electron-nucleus potential is regularized for each thermodynamic condition through a similar procedure of generating the norm-conserving pseudopotential as the PAW treatment. The cutoff radius is chosen to be less than 10% of the Wigner–Seitz radius to avoid an overlap of regularized ion spheres. The exchangecorrelation function is expressed in the local density approximation of Perdew and Zunger.<sup>47</sup> At each time step of an OFMD simulation, the electron free energy for a ionic configuration is first minimized in terms of the local electron density. Then, the classical ions are moved by the combined electronic and ionic forces, the same as in the KSMD procedure. In our OFMD simulations of silicon plasmas, we used 128 atoms in a cubic cell with a periodic boundary condition. The time step varied from  $\delta t = 0.144$  fs to  $\delta t = 6 \times 10^{-5}$  fs, respectively, for the lowest-density/temperature ( $\rho = 0.001$  g/cm<sup>3</sup> and T = 125,000 K) point and the highest-density/temperature ( $\rho = 500$  g/cm<sup>3</sup> and  $T = 10^8$  K) point. Finally, the thermodynamic EOS quantities were statistically evaluated from the MD propagation of the system (5000 to 100,000 steps depending on the density).

For each isochoric curve, we examined the EOS quantities for the overlapping temperature points between the KSMD and OFMD calculations. We make the transition from KSMD to OFMD at the temperature point where their differences are the smallest (within ~1%). Carrying out these calculations for a wide range of silicon plasma conditions, we obtained both pressure and internal energies for all the sampled density and temperature points ( $\rho = 0.001$  to 500 g/cm<sup>3</sup> and T = 2000 to  $10^8$  K). As an example, in Fig. 1 we plot the total pressures as a function of the silicon plasma temperature for each of the sampled isochoric curves. The resulting FPEOS table of silicon consists of an asymmetric grid of 28×25 density-temperature points of which 28×14 points came directly from our KSMD-OFMD calculations. Outside this temperature range, we have extrapolated our EOS data to both T=0 K and T=10<sup>10</sup> K with the guidance from both zero-temperature KSMD calculations for above-solid densities and OFMD calculations at the high-T end.

#### III. COMPARISONS BETWEEN FPEOS AND SESAME EOS

From the FPEOS table, we can derive the principal Hugoniot curve for silicon shocks by using the Rankine–Hugoniot equation. The initial state is chosen to be solid silicon ( $\rho_0 = 2.329 \text{ g/cm}^3$ ) in its diamond phase at ambient pressure ( $P_0 = 1 \text{ bar}$ ). The initial energy  $E_0$ =-5.45 eV/atom of silicon at ambient condition ( $\rho$ =2.329 g/cm<sup>3</sup> and T=300 K) is obtained from a direct KSMD calculation. We compare the FPEOS Hugoniot with the one derived from the extensively used SESAME-EOS model (SESAME 3810 table) in Fig. 2(a), in which the Hugoniot pressure spanning more than five orders of magnitude is plotted as a function of the shock density. The SESAME-EOS model was based on the chemical picture of matter, meaning that the total free energy can be decomposed into the cold curve, the ionic excitation, and the electron thermal excitation. It was typically constructed (constrained) by the best-available experimental data (typically limited). Specifically, for SESAME 3810 (Si) constructed in 1997, the EOS below the solid-liquid phase transition was based on experimental Hugoniot data.<sup>16-18</sup> For conditions above the liquid phase transition, the EOS was constructed such that the shock Hugoniot was "similar" to germanium (SESAME 3950) up to 4.4 Mbar. The ion thermal contribution is based on a Debye model with a correction for the liquid specific heat beyond the melt temperature.<sup>48</sup> The correction also ensures that in the hightemperature limit, the proper model (ideal gas) is recovered that will give a shock Hugoniot compression ratio  $\rho/\rho_0 = 4$ . The Hugoniot comparison in Fig. 2(a) indicates that under shock compression, silicon is much softer than predicted by the traditional chemical picture of materials.<sup>29</sup> For example, at a constant pressure of ~20 Mbar, the SESAME 3810 table predicted a shock density of  $\rho \approx 6.3$  g/cm<sup>3</sup>, while the FPEOS table

gives a much-higher shock density of  $\rho \approx 7.7$  g/cm<sup>3</sup>. Namely, the FPEOS table predicts that silicon under 10- to 1000-Mbar pressures is ~20% softer than SESAME 3810. For the same shock density at  $\rho = 8$  g/cm<sup>3</sup>, the SESAME 3810 model predicts a shock pressure of  $P \approx 73.4$  Mbar, which is more than  $3 \times$  higher than the FPEOS case ( $P \approx 24$  Mbar). Figure 2(a) indicates that the maximum compression  $(\rho/\rho_0)$  changes from the SESAMEpredicted value of ~4.6 to 5.0 in FPEOS. Finally, in the same figure, we have plotted the existing experimental data, 16-18 which are represented by the different symbols. These Hugoniot data were obtained from explosively driven shock experiments. To the best of our knowledge, no published data exist for laser-shock Hugoniot measurements in pressures above 10 Mbar. The opacity of Si for most VISAR laser wavelengths<sup>49</sup> is one of the hurdles for accurate shock measurements in silicon. Nevertheless, it is shown in Fig. 2 that the explosively driven shock data up to  $\sim 2$  Mbar agree well with our calculations, which seems also to indicate the softening of silicon under compression. It is noted that at the measured highest shock density of  $\rho = 4.6$  g/cm<sup>3</sup>, the SESAME-EOSpredicted pressure is at least  $2 \times$  higher than the experimental value of  $P \approx 2$  Mbar.

To further examine the properties of shocked silicon, we have calculated the heat capacity  $C_v$  along its principal Hugoniot. Because  $C_v$  is a measure of the energy change with respect to temperature at a fixed volume, it can give some indication of how rapidly the entropy is increasing with temperature in a silicon shock. The obtained  $C_v$  results are plotted in Fig. 2(b) as a function of the Hugoniot density for both *SESAME* 3810 (red dashed line) and FPEOS (blue solid line). In Fig. 2(b), we also plot three horizontal lines to indicate the expected heat capacities for ideal-gas plasmas of three different ionization stages of Si<sup>4+</sup>, Si<sup>12+</sup>, and Si<sup>14+</sup>, respectively. For instance, the lowest black dashed line

represents the ideal-gas plasma that includes only Si<sup>4+</sup> and free electrons without any interactions. Since the electron ionization process acts like a "heat sink" for the system, one expects the heat capacity to increase during the ionization of bound electrons. This is especially true for innermost shell electrons because of the large energy gaps between the L-shell and K-shell electrons. This is exactly what can be seen in Fig. 2(b): the FPEOS calculation (blue solid line) gives a peak of  $C_v$  near the peak compression at  $\rho$ . 11.5 g/cm<sup>3</sup> [see Fig. 2(a)]. After the 1*s*-electron ionization is completed, the heat capacity approaches the ideal-gas limit (pink long-dashed line) as a fully ionized Si plasma is formed. The SESAME 3810-predicted  $C_v$  has a similar trend, but the same value of  $C_v$  is reached at a smaller density. In other words, at the same density the FPEOS-predicted  $C_v$ is ~50% lower than the SESAME 3810 case, meaning that less entropy increase is expected in FPEOS. By referring to the ideal-gas  $C_{v}$ , one can argue that the same ionization stage is first reached at much-lower densities in SESAME 3810 than in FPEOS. Again, all of these features are consistent with the higher compressibility of silicon predicted by FPEOS.

Next, we compare the pressure and internal energy of silicon plasmas for off-Hugoniot conditions between FPEOS (blue solid line) and *SESAME* 3810 (red dashed line) in Figs. 3–5. Figures 3(a) and 4(a) show the pressure as a function of plasma temperature, respectively, for silicon densities of  $\rho = 5$  g/cm<sup>3</sup> and  $\rho = 10$  g/cm<sup>3</sup>, while the internal energy comparisons are made in Figs. 3(b) and 4(b). One sees in Fig. 3(a) that the *SESAME* pressure is ~10% lower than FPEOS for low temperatures of  $T < 10^4$  K, but it reverses for the high-*T* regime ( $10^4 < T < 10^6$ ) with a "crossover" temperature at  $T \sim$  $10^4$  K (~1 eV). The pressure difference between FPEOS and *SESAME* 3810 reaches a maximum of ~50% in the warm dense regime ( $T \sim 10^5$  K) at this density ( $\rho = 5$  g/cm<sup>3</sup>). This is the regime in which both electron degeneracy and strong ion–ion coupling play significant roles in determining the EOS. The internal energy comparison in Fig. 3(b) shows a similar trend, although the difference is only ~20%. For high temperatures of  $T > 10^6$  K, both FPEOS and *SESAME* 3810 are in good agreement with each other, as the two EOS tables correctly approach the ideal gas limit. Figure 4 shows similar EOS comparisons for  $\rho = 10$  g/cm<sup>3</sup>. At this higher density, we see the crossover temperature now moves to near ~10<sup>5</sup> K (~10 eV), and the maximum difference in pressure between FPEOS and *SESAME* 3810 reduces to ~20%. The difference in internal energy in Fig. 4(b) is also reduced when compared to Fig. 3(b).

We explore two other isochores at high densities of  $\rho = 50$  g/cm<sup>3</sup> and  $\rho = 500$  g/cm<sup>3</sup>, respectively, in Figs. 5(a) and 5(b). Again, the two panels compare the pressures of FPEOS with *SESAME* 3810 at various temperatures. Figure 5(b) indicates that both FPEOS and *SESAME* 3810 are very close to each other at this high density of  $\rho = 500$  g/cm<sup>3</sup>, even though *SESAME* 3810 gives a slightly higher pressure over the entire temperature range (no more crossover is seen between the two EOS's). Both EOS tables are in better agreement with each other in this electron-degeneracy–dominated regime. For the intermediate density of  $\rho = 50$  g/cm<sup>3</sup>, Fig. 5(a) still shows a trend similar to the one seen in Figs. 3 and 4. Namely, the *SESAME* 3810 model still underestimates the pressure for the low-*T* regime (*T* < 10<sup>6</sup> K). With these large EOS differences identified in both on-Hugoniot and off-Hugoniot warm-dense-plasma conditions, we expect to see significant effects on HED plasma simulations between using the newly established FPEOS and using the *SESAME* 3810 for silicon.

Finally, we examine the isothermal comparisons between FPEOS and SESAME-3810 in Fig. 6 for T=15,625 K [(a) and (b)] and T=125,000 K [(c) and (d)], respectively. To clearly show the discrepancies, we plot the percentage differences between the two EOS models. As we can see, the differences reach over ~50% in pressure and a factor of ~3 in internal energy for these relatively lower temperatures. For densities of  $\rho \le 12$ g/cm<sup>3</sup>, the significantly-lower internal energy in FPEOS is the cause of the more compressible Hugoniot we saw in Fig.2. We have noted that the cold curve predicted from KSMD is also quite different from SESAME-3810. Once again, it is expected that these larger discrepancies in off-Hugoniot conditions might have significant implications for HED plasma simulations.

## IV. FPEOS EFFECTS ON HED PLASMA SIMULATIONS INVOLVING SILICON

To examine the EOS effects on HED plasma simulations, we have implemented our FPEOS table of silicon into our radiation–hydrodynamics code *LILAC*. We have extrapolated our EOS results for temperatures outside our calculation range (2000 K to  $10^8$  K). With the implementation of the FPEOS table, we can investigate its effects on HED simulations involving silicon plasmas. Since in an ICF implosion the capsule generally undergoes a path sweeping through many different density and temperature conditions, integrated ICF implosion simulations would be more suitable for examining EOS effects. As an example, we consider a NIF-type direct-drive implosion with the target and pulse shape shown in Fig. 7. The  $\phi = 2.4$ -mm capsule is made of a 40- $\mu$ m Si layer filled with 3 atm of deuterium–tritium (DT) gas. The step laser pulse has a total

energy of 800 kJ, with a duration of 8 ns. Figures 8-11 show the LILAC simulation results using either FPEOS (blue solid line) or SESAME 3810 (red dashed line) for silicon. Both simulations used the same nonlocal thermal-transport model<sup>50</sup> and inversebremsstrahlung absorption with cross-beam energy transfer modeling.<sup>51</sup> For DT gas, the two simulations used the same FPEOS table 52,53 and the same first-principles opacity table<sup>54</sup> of DT, so that the EOS tests are solely focused on the silicon ablator layer. In Fig. 8, we plot the density and temperature profile snapshot at t = 0.9 ns as a function of target radius for the two simulations. At this time, the shock is still propagating inside the Si layer (the shock front is located at  $R \sim 1180 \ \mu m$ ). Figure 8 indicates that (1) the shock density in FPEOS is ~20% higher than the SESAME simulation and (2) the shock in the SESAME simulation is ahead of the FPEOS case, giving a shock-speed difference of  $\sim 10\%$ . These features can be understood by considering the softening of silicon shock in FPEOS (see Fig. 2). Namely, the identical laser drive gives the same ablation pressure in the two simulations; for the same shock pressure  $(P_S)$ , the FPEOS simulation will give ~20%-higher shock density ( $\rho_{\rm S}$ ) as the Hugoniot curve seen in Fig. 2(a). Since the shock speed depends on the shock density through  $V_{\rm S} = \sqrt{P_{\rm S}/\rho_0} / \sqrt{1 - \rho_0/\rho_{\rm S}}$ , one can see that for the same  $P_{\rm S}$ , the ~20%-higher shock density in FPEOS will give an ~10%-smaller shock speed than the SESAME case. Figure 8 also indicates the shock temperature is  $\sim 20\%$  higher in FPEOS.

As the implosion proceeds, Fig. 9 shows the density and temperature profiles during the in-flight stage of t = 5.4 ns [Fig. 9(a)] and at the end of acceleration of t = 7.9 ns [Fig. 9(b)]. One sees from Fig. 9 that the peak density of the shell from the FPEOS

simulation is always ~20% higher than the SESAME 3810 case. This can be attributed to the larger compressibility of silicon predicted by FPEOS. Except for the difference in peak density, the two simulations give very similar density and temperature profiles for the imploding shell. Some difference in the back surface of the shell appears only at the end of the acceleration phase, as indicated by Fig. 9(b). Note that the coronal plasma conditions are also very similar in the two cases, as the EOS difference becomes very small at high temperatures of  $T > 10^6$  K. Figure 9 also shows an interesting doubleablation-front feature, which can develop in such mid-Z-ablator implosions<sup>55</sup> because of the significant radiation preheat from coronal emissions. The  $\sim 20\%$  difference in peak density in the two simulations can have significant consequence when the imploding shell stagnates. Figure 10 displays the situation at the time of peak neutron production (near peak compression). Again, the figure shows the density and ion temperature as functions of the target radius. The maximum density reached in the FPEOS simulation is  $\rho_{\rm p}$  = 271.9 g/cm<sup>3</sup>, in contrast to the SESAME 3810–predicted  $\rho_p$  = 185.5 g/cm<sup>3</sup>. The Si shell is converged slightly more in FPEOS than SESAME, resulting in a somewhat different hotspot radius ( $R_{\rm hs}$  = 30.5  $\mu$ m versus  $R_{\rm hs}$  = 33.6  $\mu$ m). Consequently, the maximum ion temperature is increased from  $T_i \approx 3.07$  keV (SESAME) to  $T_i \approx 3.45$  keV (FPEOS).

Finally, we plot the history of the compression areal density ( $\rho R$ ) and neutron yield, respectively, in Figs. 11(a) and 11(b) for the two implosion simulations. One sees from Fig. 11(a) that the peak areal density reaches a value of  $\rho R = 1.38$  g/cm<sup>2</sup> in FPEOS, which is ~30% higher than the *SESAME* simulation. The total neutron yield predicted by FPEOS, shown by Fig. 11(b), is increased by more than ~70% with respect to the *SESAME* case [ $Y = 5.0 \times 10^{14}$  (FPEOS) versus  $Y = 2.9 \times 10^{14}$  (*SESAME*)]. As a result,

the EOS difference can have significant consequences on predicting the 1-D target performance. This illustrates the importance of having a more-accurate EOS table to the 1-D hydrodynamic designs of ICF/HED experiments.

## V. CONCLUSION

We have applied DFT-based molecular-dynamics simulation methods for investigating the EOS of silicon, spanning a wide range of plasma conditions from  $\rho =$ 0.001 to 500 g/cm<sup>3</sup> and T = 2000 to  $10^8$  K. The resulting pressures and internal energies have been assembled into a first-principles equation-of-state table, which is studied in detail by comparing it with the extensively used SESAME 3810 table of silicon. We found that the shock Hugoniot of silicon is ~20% softer in FPEOS than SESAME 3810. For off-Hugoniot warm-dense-plasma conditions, the pressure difference can reach ~50% between FPEOS and SESAME 3810, while the internal energy difference is within ~20%. After implementing the FPEOS table of silicon into our 1-D radiation–hydrodynamics code LILAC, we tested its effects on HED plasma simulation by carrying out hydrosimulations of an ICF implosion with a Si shell using either FPEOS or SESAME 3810. The simulation results indicated that (a) the FPEOS-predicted shock density is  $\sim 20\%$ higher than the SESAME 3810 case (accordingly, the shock speed is  $\sim 10\%$  lower in the former case); (b) the peak density of the imploding Si shell is  $\sim 20\%$  larger in FPEOS than in SESAME; (c) the maximum density at peak compression is different by  $\sim 40\%$ ; and (d) the final areal density and yield predicted by FPEOS are also significantly varied, respectively, by  $\sim 30\%$  and  $\sim 70\%$ , with respect to the SESAME simulation. The observed differences in target performance can be attributed to the different compressibility of silicon predicted by FPEOS. These studies illustrate the importance of having a moreaccurate EOS table in order to precisely design ICF/HED experiments. Hopefully these results will facilitate shock-wave experiments in the untested high-pressure (>10-Mbar) regime.

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#### References

- G. J. Cheng, M. Cai, D. Pirzada, M. J. F. Guinel, and M. G. Norton, J. Manuf. Sci. Eng. 130, 011008 (2008).
- Y. Zhang, T. Sekine, H. He, Y. Yu, F. Liu, and M. Zhang, Geophys. Res. Lett. 41, 4554 (2014).
- 3. H. Sai, T. Matsui, T. Koida, K. Matsubara, M. Kondo, S. Sugiyama, H. Katayama, Y. Takeuchi, and I. Yoshida, Appl. Phys. Lett. **106**, 213902 (2015).

- A. Benuzzi-Mounaix, S. Mazevet, R. Ravasio, T. Vinci, A. Denoeud, M. Koenig,
  N. Amadou, E. Brambrink, F. Festa, A. Levy *et al.*, Phys. Scr. 2014, 014060 (2014).
- 5. W. D. Langer and A. E. Glassgold, Astrophys. J. **352**, 123 (1990).
- P. Schilke, C. M. Walmsley, G. Pineau des Forêts, and D. R. Flower, Astron. Astrophys. 321, 293 (1997).
- M. J. Edwards, J. D. Lindl, B. K. Spears, S. V. Weber, L. J. Atherton, D. L. Bleuel, D. K. Bradley, D. A. Callahan, C. J. Cerjan, D. Clark *et al.*, Phys. Plasmas 18, 051003 (2011).
- R. L. McCrory, R. Betti, T. R. Boehly, D. T. Casey, T. J. B. Collins, R. S. Craxton, J. A. Delettrez, D. H. Edgell, R. Epstein, J. A. Frenje *et al.*, Nucl. Fusion 53, 113021 (2013).
- R. S. Craxton, K. S. Anderson, T. R. Boehly, V. N. Goncharov, D. R. Harding, J.
  P. Knauer, R. L. McCrory, P. W. McKenty, D. D. Meyerhofer, J. F. Myatt *et al.*,
  Phys. Plasmas 22, 110501 (2015).
- S. W. Haan, J. D. Lindl, D. A. Callahan, D. S. Clark, J. D. Salmonson, B. A. Hammel, L. J. Atherton, R. C. Cook, M. J. Edwards, S. Glenzer *et al.*, Phys. Plasmas 18, 051001 (2011).
- S. X. Hu, G. Fiksel, V. N. Goncharov, S. Skupsky, D. D. Meyerhofer, and V. A. Smalyuk, Phys. Rev. Lett. 108, 195003 (2012).
- G. Fiksel, S. X. Hu, V. N. Goncharov, D. D. Meyerhofer, T. C. Sangster, V. A. Smalyuk, B. Yaakobi, M. J. Bonino, and R. Jungquist, Phys. Plasmas 19, 062704 (2012).

- S. X. Hu, D. T. Michel, D. H. Edgell, D. H. Froula, R. K. Follett, V. N. Goncharov, J. F. Myatt, S. Skupsky, and B. Yaakobi, Phys. Plasmas 20, 032704 (2013).
- J. F. Myatt, H. X. Vu, D. F. DuBois, D. A. Russell, J. Zhang, R. W. Short, and A. V. Maximov, Phys. Plasmas 20, 052705 (2013).
- V. N. Goncharov, T. C. Sangster, R. Betti, T. R. Boehly, M. J. Bonino, T. J. B.
  Collins, R. S. Craxton, J. A. Delettrez, D. H. Edgell, R. Epstein *et al.*, Phys.
  Plasmas 21, 056315 (2014).
- 16. M. N. Pavlovskii, Sov. Phys.-Solid State 9, 2514 (1968).
- 17. W. H. Gust and E. B. Royce, J. Appl. Phys. 42, 1897 (1971).
- 18. T. Goto, T. Sato, and Y. Syono, Jpn. J. Appl. Phys. **21**, L369 (1982).
- L. Loveridge-Smith, A. Allen, J. Belak, T. Boehly, A. Hauer, B. Holian, D. Kalantar, G. Kyrala, R. W. Lee, P. Lomdahl *et al.*, Phys. Rev. Lett. **86**, 2349 (2001).
- 20. P. Celliers, A. Ng, G. Xu, and A. Forsman, Phys. Rev. Lett. 68, 2305 (1992).
- 21. A. Ng, P. Celliers, G. Xu, and A. Forsman, Phys. Rev. E 52, 4299 (1995).
- 22. Th. Löwer, V. N. Kondrashov, M. Basko, A. Kendl, J. Meyer-ter-Vehn, R. Sigel, and A. Ng, Phys. Rev. Lett. **80**, 4000 (1998).
- 23. E. J. Reed, J. D. Joannopoulos, and L. E. Fried, AIP Conf. Proc. 620, 343 (2002).
- I. I. Oleynik, S. V. Zybin, M. L. Elert, and C. T. White, AIP Conf. Proc. 845, 413 (2006).
- 25. G. Mogni, A. Higginbotham, K. Gaál-Nagy, N. Park, and J. S. Wark, Phys. Rev. B. 89, 064104 (2014).

- D. C. Swift, G. J. Ackland, A. Hauer, and G. A. Kyrala, Phys. Rev. B 64, 214107 (2001).
- 27. B. Militzer and K. P. Driver, Phys. Rev. Lett. 115, 176403 (2015).
- 28. O. Strickson and E. Artacho, Phys. Rev. B **93**, 094107 (2016).
- S. X. Hu, B. Militzer, L. A. Collins, K. P. Driver, and J. D. Kress, Phys. Rev. B 94, 094109 (2016).
- B. I. Bennett, J. D. Johnson, G. I. Kerley, and G. T. Rood, Los Alamos National Laboratory, Los Alamos, NM, Report LA-7130, 197818 (1978).
- R. M. More, K. H. Warren, D. A. Young, and G. B. Zimmerman, Phys. Fluids 31, 3059 (1988).
- J. Delettrez, R. Epstein, M. C. Richardson, P. A. Jaanimagi, and B. L. Henke, Phys. Rev. A 36, 3926 (1987).
- L. Collins, I. Kwon, J. Kress, N. Troullier, and D. Lynch, Phys. Rev. E 52, 6202 (1995).
- 34. J. G. Clérouin and S. Bernard, Phys. Rev. E 56, 3534 (1997).
- L. A. Collins, S. R. Bickham, J. D. Kress, S. Mazevet, T. J. Lenosky, N. J. Troullier, and W. Windl, Phys. Rev. B 63, 184110 (2001).
- 36. M. P. Desjarlais, Phys. Rev. B 68, 064204 (2003).
- C. Pierleoni, D. M. Ceperley, B. Bernu, and W. R. Magro, Phys. Rev. Lett. 73, 2145 (1994).
- R. C. Clay, M. Holzmann, D. M. Ceperley, and M. A. Morales, Phys. Rev. B 93, 035121 (2016).

- S. Root, L. Shulenburger, R. W. Lemke, D. H. Dolan, T. R. Mattsson, and M. P. Desjarlais, Phys. Rev. Lett. 115, 198501 (2015).
- 40. W. Kohn and L. J. Sham, Phys. Rev. 140, A1133 (1965).
- 41. F. Lambert, J. Clérouin, and G. Zérah, Phys. Rev. E 73, 016403 (2006).
- 42. G. Kresse and J. Hafner, Phys. Rev. B 47, 558 (1993).
- 43. G. Kresse and J. Hafner, Phys. Rev. B 49, 14251 (1994).
- 44. G. Kresse and J. Furthmüller, Phys. Rev. B 54, 11169 (1996).
- J. P. Perdew, K. Burke, and M. Ernzerhof, Phys. Rev. Lett. 77, 3865 (1996); J. P.
  Perdew, K. Burke, and M. Ernzerhof, Phys. Rev. Lett. 78, 1396(E) (1997).
- 46. P. Hohenberg and W. Kohn, Phys. Rev. **136**, B864 (1964).
- 47. J. P. Perdew and A Zunger, Phys. Rev. B 23, 5048 (1981).
- 48. J. D. Johnson, High Press. Res. 6, 277 (1991).
- 49. P. M. Celliers, G. W. Collins, L. B. Da Silva, D. M. Gold, R. Cauble, R. J. Wallace, M. E. Foord, and B. A. Hammel, Phys. Rev. Lett. 84, 5564 (2000).
- V. N. Goncharov, T. C. Sangster, P. B. Radha, R. Betti, T. R. Boehly, T. J. B. Collins, R. S. Craxton, J. A. Delettrez, R. Epstein, V. Yu. Glebov *et al.*, Phys. Plasmas 15, 056310 (2008).
- I. V. Igumenshchev, D. H. Edgell, V. N. Goncharov, J. A. Delettrez, A. V. Maximov, J. F. Myatt, W. Seka, A. Shvydky, S. Skupsky, and C. Stoeckl, Phys. Plasmas 17, 122708 (2010).
- S. X. Hu, B. Militzer, V. N. Goncharov, and S. Skupsky, Phys. Rev. Lett. 104, 235003 (2010).

- S. X. Hu, B. Militzer, V. N. Goncharov, and S. Skupsky, Phys. Rev. B 84, 224109 (2011).
- 54. S. X. Hu, L. A. Collins, V. N. Goncharov, T. R. Boehly, R. Epstein, R. L. McCrory, and S. Skupsky, Phys. Rev. E **90**, 033111 (2014).
- M. Lafon, R. Betti, K. S. Anderson, T. J. B. Collins, R. Epstein, P. W. McKenty,
  J. F. Myatt, A. Shvydky, and S. Skupsky, Phys. Plasmas 22, 032703 (2015).

### **Figure captions**

FIG. 1. (Color online) The pressure as a function of silicon plasma temperature for all densities ( $\rho = 0.001$  to 500 g/cm<sup>3</sup>) scanned by our first-principles (KSMD + OFMD) calculations.

FIG. 2. (Color online) (a) The shock Hugoniot of silicon predicted by FPEOS (blue solid line) is compared to the EOS-model *SESAME* 3810 (red dashed line), a recent KSMD study (green dashed line),<sup>28</sup> and available experiments (various symbols) by Pavlovskii *et al.*,<sup>16</sup> Gust and Royce,<sup>17</sup> and Goto *et al.*<sup>18</sup> (b) A comparison of heat capacity calculated from FPEOS and *SESAME* 3810 along the principal Hugoniot. The diamond phase silicon ( $\rho_0 = 2.329$  g/cm<sup>3</sup>) is chosen as the initial state for the Hugoniot calculations.

FIG. 3. (Color online) The off-Hugoniot equation-of-state comparisons between FPEOS and *SESAME* 3810. The (a) pressures and (b) internal energies are plotted as functions of temperature for a silicon density of  $\rho = 5$  g/cm<sup>3</sup>.

FIG. 4. (Color online) Same as Fig. 3 except for a different silicon density of  $\rho = 10$  g/cm<sup>3</sup>.

FIG. 5. (Color online) The pressure comparisons between FPEOS and *SESAME* 3810 for higher densities of silicon plasmas: (a)  $\rho = 50$  g/cm<sup>3</sup> and (b)  $\rho = 500$  g/cm<sup>3</sup>.

FIG. 6. (Color online) The percentage difference of pressure and internal energy between FPEOS and *SESAME* 3810 as a function of silicon density for the isotherms of T=15,625 K [(a) and (b)] and T=125,000 K [(c) and (d)].

FIG. 7. (Color online) The laser pulse shape and target dimensions for implosion simulations to test the silicon-EOS effects. The capsule consists of a 40- $\mu$ m-thick silicon shell ( $\rho_0 = 2.329 \text{ g/cm}^3$ ) filled with 3 atm of DT gas. The initial target radius  $R = 1200 \ \mu$ m. The total laser energy is 800 kJ with 8-ns pulse duration, available on NIF-type facilities.

FIG. 8. (Color online) Comparisons of density and electron temperature profiles predicted by the two *LILAC* simulations using FPEOS (blue solid lines) and *SESAME* 3810 (red dashed line) EOS models. The snapshot was taken at t = 0.9 ns, when the first shock was still propagating in the silicon layer.

FIG. 9. (Color online) Same as Fig. 8 but for different implosion times: (a) t = 5.4 ns (in flight of the imploding shell) and (b) t = 7.9 ns (the end of shell acceleration).

FIG. 10. (Color online) Comparisons of density and ion temperature profiles predicted by the two *LILAC* simulations using FPEOS (blue solid lines) and *SESAME* 3810 (red dashed line) EOS models. The snapshot is shown for the instant at their peak neutron production ( $t \sim 9.0$  ns).

FIG. 11. (Color online) Comparisons of (a) the areal density  $\rho R$  and (b) the total neutron yield as functions of time, for the two *LILAC* simulations using FPEOS (blue solid lines) and *SESAME* 3810 (red dashed line) EOS models.

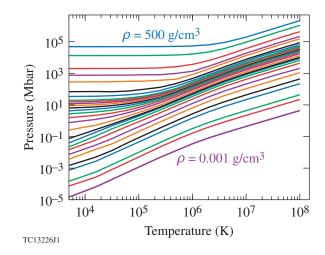


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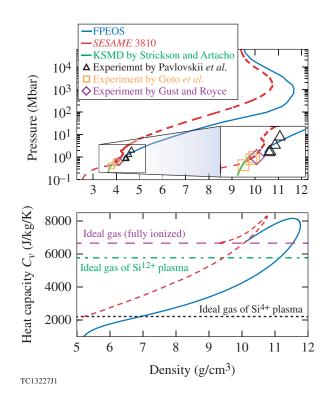


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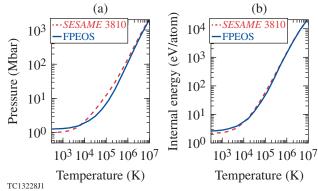


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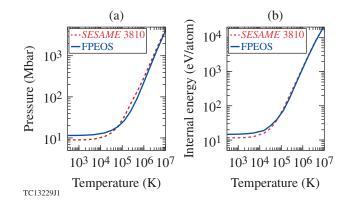


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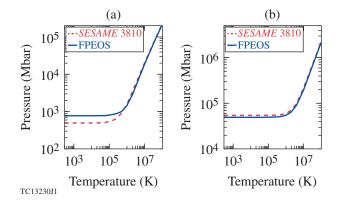


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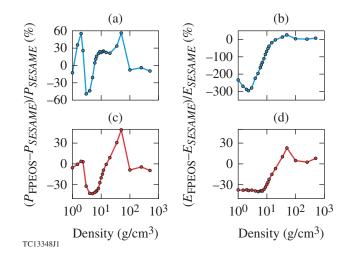


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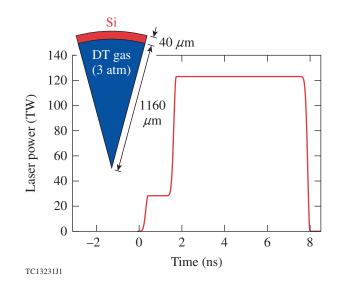


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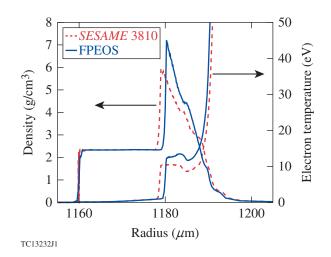


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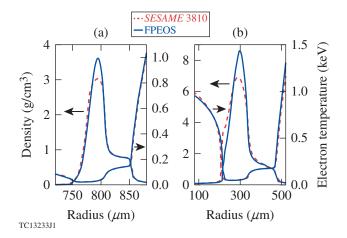


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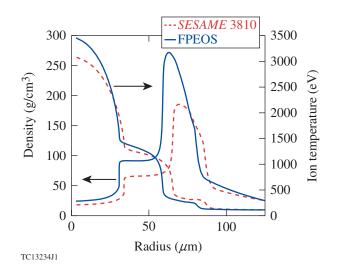


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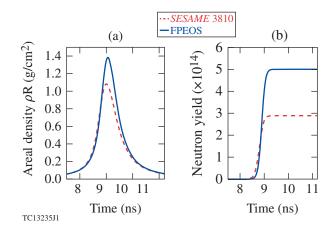


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